

QUALITY & RELIABILITY ENGINEERING FIT and MTTF Calculation Report

PN Family Series	MBRAD8200H
Part Description	8A, 200V Schottky Barrier Surface Mount Rectifier
Package Type	Thin DPAK

Test Variables:

Stress Test	=	HTRB	
No. of failures	=	0	units
Sample Size	=	308	units
Test Duration	=	1000	hours
Total device hours	=	308000	hours
Accelerated Temp (Ta)	=	150	° C
Operating Temp (Tu)	=	50	° C
Activation Energy (Ea)	=	0.7	eV
Confidence Level	=	90	%
Boltzman's Constant (k)	=	8.617E-05	eV / °K

Calculations:

Chi squared value = **4.6051702** @ 90% Confidence Level

Failure Rate (@accelerated condition) = $\frac{\text{(Chi squared value)}}{2^*(\text{Sample Size})^*(\text{Test Duration})}$

= 7475.93 FIT

Acceleration Factor, AF = $e^{(Ea/k)(1/Tu - 1/Ta)}$

= 382.0861577

Results:

Failure Rate (@operating condition)	= (Failure Rate @accelerated condition) / (AF)
	= 19.57 FIT

Mean Time to Failure (MTTF) = 51108876 hours

= **5834** years